May 1995



54F/74F521 8-Bit Identity Comparator

General Description

The 'F521 is an expandable 8-bit comparator. It compares two words of up to eight bits each and provides a LOW output when the two words match bit for bit. The expansion input $\bar{I}_{A=B}$ also serves as an active LOW enable input.

Features

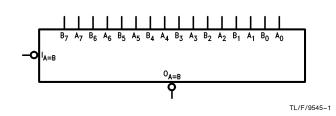
- Compares two 8-bit words in 6.5 ns typ
- Expandable to any word length
- 20-pin package

Commercial	Military	Package Number	Package Description
74F521PC		N20A	20-Lead (0.300" Wide) Molded Dual-In-Line
	54F521DM (Note 2)	J20A	20-Lead Ceramic Dual-In-Line
74F521SC (Note 1)		M20B	20-Lead (0.300" Wide) Molded Small Outline, JEDEC
74F521SJ (Note 1)		M20D	20-Lead (0.300" Wide) Molded Small Outline, EIAJ
74F521MSA (Note 1)		MSA20	20-Lead Molded Shrink Small Outline, EIAJ type II

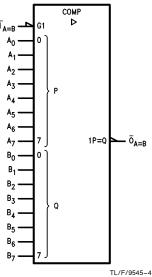
Note 1: Devices also available in 13" reel. Use suffix = SCX, SJX and MSAX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB.

Logic Symbols



IEEE/IEC



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RRD-B30M75/Printed in U. S. A.

Unit Loading/Fan Out

		54F/74F			
Pin Names	Description	U.L. HIGH/LOW	Input I _{IH} /I _{IL} Output I _{OH} /I _{OL}		
A ₀ -A ₇	Word A Inputs	1.0/1.0	20 μA/-0.6 mA		
B ₀ -B ₇	Word B Inputs	1.0/1.0	20 μA/-0.6 mA		
$\bar{I}_{A=B}$	Expansion or Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA		
$\overline{O}_{A=B}$	Identity Output (Active LOW)	50/33.3	−1 mA/20 mA		

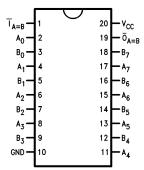
Truth Table

Inj	Output		
$ar{I}_{f A}={f B}$	A, B	$\overline{O}_{A} = B$	
L	$A = B^*$	L	
L	A eq B	Н	
Н	$A = B^*$	Н	
Н	$A \neq B$	Н	

 $\begin{array}{ll} H = \text{HIGH Voltage Level} \\ L = \text{LOW Voltage Level} \\ *A_0 = B_0, \, A_1 = B_1, \, A_2 = B_2, \, \text{etc.} \end{array}$

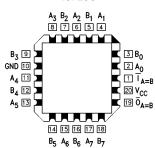
Connection Diagrams

Pin Assignment for DIP, SOIC, SSOP and Flatpak



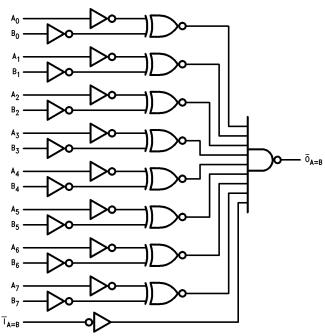
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Pin Assignment for LCC



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Logic Diagram



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Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

 $\begin{array}{lll} \text{Storage Temperature} & -65^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \text{Ambient Temperature under Bias} & -55^{\circ}\text{C to} + 125^{\circ}\text{C} \\ \text{Junction Temperature under Bias} & -55^{\circ}\text{C to} + 175^{\circ}\text{C} \\ \text{Plastic} & -55^{\circ}\text{C to} + 150^{\circ}\text{C} \\ \end{array}$

V_{CC} Pin Potential to

Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ll} \text{Standard Output} & -0.5 \text{V to V}_{\text{CC}} \\ \text{TRI-STATE} \tiny{\textcircled{\tiny{\$}}} \text{ Output} & -0.5 \text{V to } +5.5 \text{V} \end{array}$

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA)

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

Recommended Operating Conditions

Free Air Ambient Temperature

Supply Voltage

Military + 4.5V to + 5.5V Commercial + 4.5V to + 5.5V

DC Electrical Characteristics

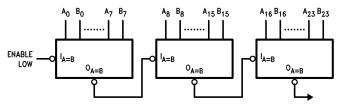
Symbol	Parameter		54F/74F			Units	v _{cc}	Conditions	
			Min	Тур	Max	Onits	VCC	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V_{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V_{CD}	Input Clamp Diode Voltage				-1.2	V	Min	$I_{\text{IN}} = -18 \text{ mA}$	
V _{OH}	Output HIGH Voltage	54F 10% V _{CC} 74F 10% V _{CC} 74F 5% V _{CC}	2.5 2.5 2.7			V	Min	$I_{OH} = -1 \text{ mA}$ $I_{OH} = -1 \text{ mA}$ $I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW Voltage	54F 10% V _{CC} 74F 10% V _{CC}			0.5 0.5	٧	Min	$I_{OL} = 20 \text{ mA}$ $I_{OL} = 20 \text{ mA}$	
I _{IH}	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Max	$V_{IN} = 2.7V$	
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	V _{IN} = 7.0V	
ICEX	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Max	$V_{OUT} = V_{CC}$	
V_{ID}	Input Leakage Test	74F	4.75			V	0.0	$I_{\text{ID}} = 1.9 \mu\text{A}$ All Other Pins Grounded	
l _{OD}	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
Ios	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V	
Icch	Power Supply Current			21	32	mA	Max	V _O = HIGH	

AC Electrical Characteristics

	Parameter	$74F$ $T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			54F T _A , V _{CC} = Mil C _L = 50 pF		$74F$ $T_{A}, V_{CC} = Com$ $C_{L} = 50 \text{ pF}$		Units
Symbol									
		Min	Тур	Max	Min	Max	Min	Max	
t _{PLH}	Propagation Delay A_n or B_n to $\overline{O}_{A=B}$	3.0 4.5	7.0 7.0	10.0 10.0	3.0 4.0	14.0 15.0	3.0 4.0	11.0 11.0	ns
t _{PLH} t _{PHL}	Propagation Delay $\overline{I}_{A=B}$ to $\overline{O}_{A=B}$	3.0 3.5	5.0 6.5	6.5 9.0	3.0 3.5	8.5 13.5	3.0 3.5	7.5 10.0	ns

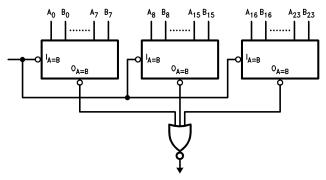
Applications

Ripple Expansion



TL/F/9545-6

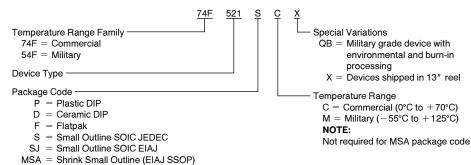
Parallel Expansion



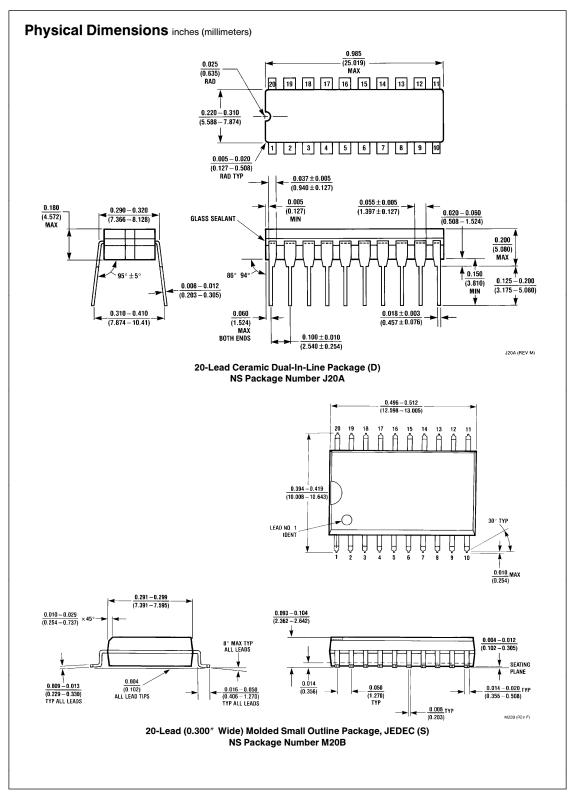
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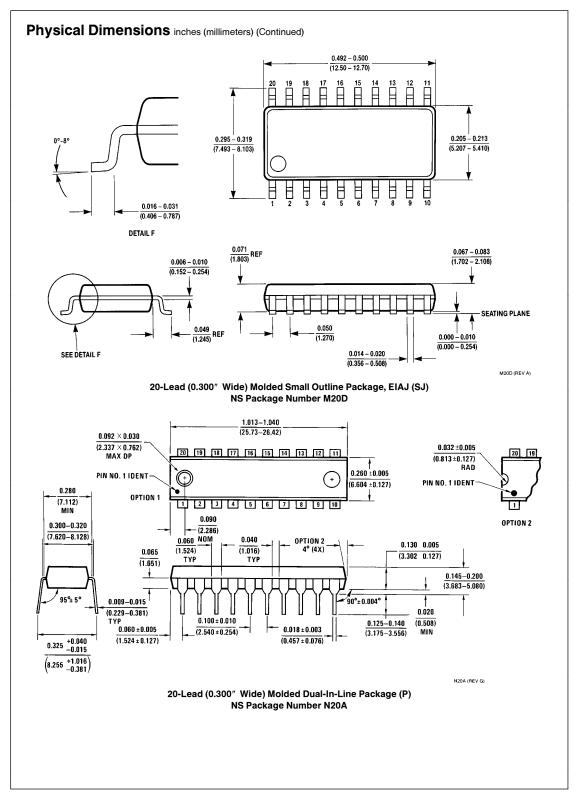
Ordering Information

The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:

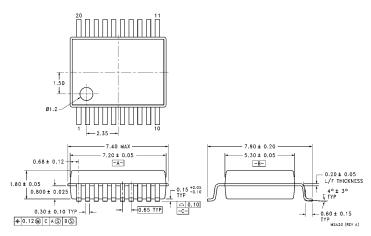


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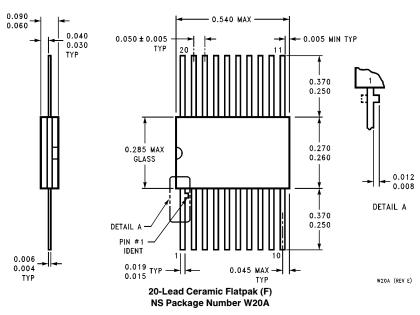


Physical Dimensions inches (millimeters) (Continued)



20-Lead (0.300" Wide) Molded Shrink Outline Package, EIAJ, Type II (MSA) NS Package Number MSA20

Physical Dimensions inches (millimeters) (Continued)



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